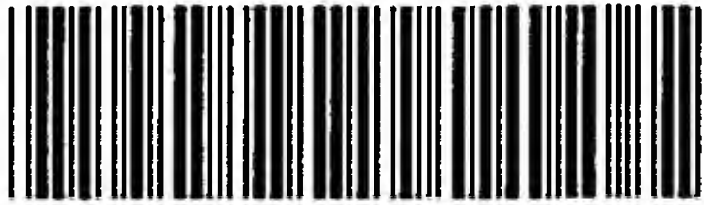


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,463	CHEN ET AL.	
	Examiner	Art Unit	
	SIMON D. NGUYEN	2618	

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455	87,125	6/30/2006	SDN
	169.2		
	180.4		
	191.2		
	193.3		
	289		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	6/30/2006	SDN